

# INTERNATIONAL STANDARD

**IEC**  
**60068-2-1**

1990

AMENDMENT 2  
1994-05

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Amendment 2

**Environmental testing –**

**Part 2:**

**Tests – Tests A: Cold**

*This **English-language** version is derived from the original **bilingual** publication by leaving out all French-language pages. Missing page numbers correspond to the French-language pages.*

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## FOREWORD

This amendment has been prepared by sub-committee 50B: Climatic tests, of IEC technical committee 50: Environmental testing.

The text of this amendment is based on the following documents:

DIS	Report on voting
50B(CO)339	50B(CO)343

Full information on the voting for the approval of this amendment can be found in the report on voting indicated in the above table.

It also incorporates the content of the Corrigendum, proposed in document 50B(Secretariat)349 and some minor editorial changes.

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Page 35 - *Method A*

*Add:*

A flow diagrammatic representation of outline of method A is given in appendix D.

Page 37 - *Method B*

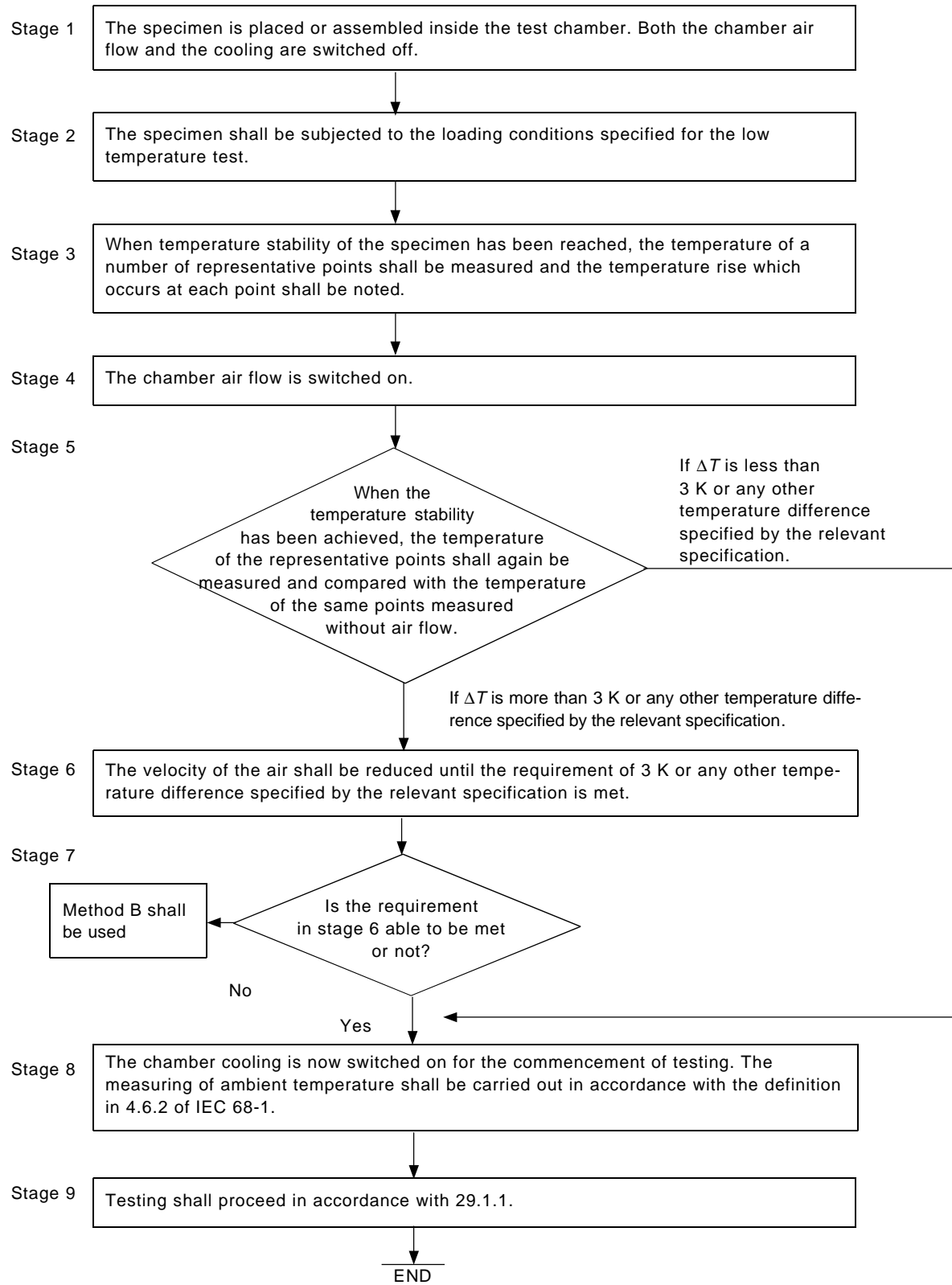
*Add:*

A flow diagrammatic representation of outline of method B is given in appendix E.

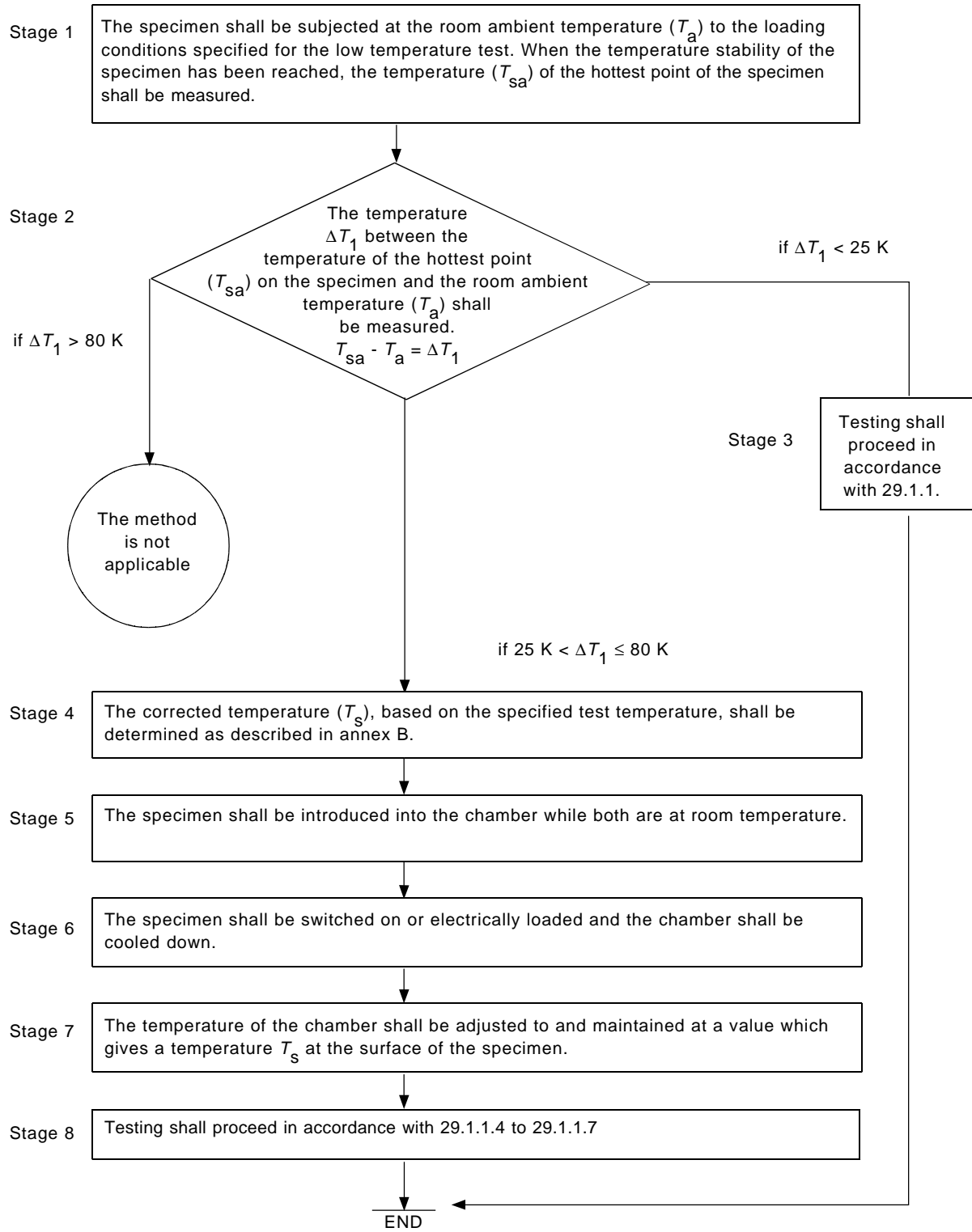
Following page 43

*Add the following new annexes D and E:*

## Annex D

Flow diagrammatic representation of outline  
of method A of test Ad (29.1.2)

## Annex E

Flow diagrammatic representation of outline  
of method B of test Ad (29.1.2)



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